

<b>Notice of References Cited</b>	Application/Control No. 10/549,910		Applicant(s)/Patent Under Reexamination NAKAJIMA ET AL.	
	Examiner CYNTHIA SZEWCZYK		Art Unit 4128	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,240,816	12-1980	McMaster et al.	65/60.5
*	B	US-4,689,247	08-1987	Doty et al.	427/126.1
*	C	US-4,349,371	09-1982	Van Laethem et al.	65/60.4
*	D	US-6,156,409	12-2000	Doushita et al.	428/143
*	E	US-6,408,743	06-2002	Niwa et al.	101/35
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Lewis, Richard J., "glass", Hawley's Condensed Chemical Dictionary, 2002, John Wiley & Sons, Inc., 14th Edition			
	V	Waibel, Friedrich et al., "Properties of TiO <sub>x</sub> films prepared by electron-beam evaporation of titanium and titanium suboxides" Applied Optics, Vol. 42, No. 22, August 1, 2003, p. 4590-4593			
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.